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# FDMS4435BZ

## P-Channel PowerTrench<sup>®</sup> MOSFET -30 V, -18 A, 20 mΩ

### Features

- Max  $r_{DS(on)}$  = 20 mΩ at  $V_{GS} = -10$  V,  $I_D = -9.0$  A
- Max  $r_{DS(on)}$  = 37 mΩ at  $V_{GS} = -4.5$  V,  $I_D = -6.5$  A
- Extended  $V_{GSS}$  range (-25 V) for battery applications
- High performance trench technology for extremely low  $r_{DS(on)}$
- High power and current handling capability
- HBM ESD protection level >7 kV typical (Note 4)
- 100% UIL tested
- Termination is Lead-free and RoHS Compliant

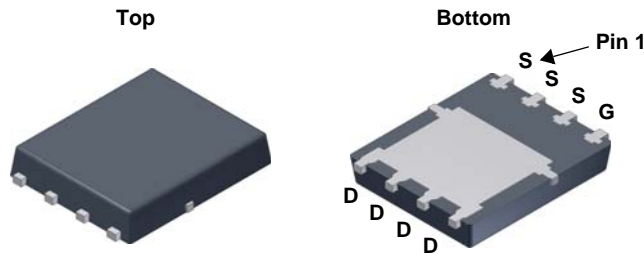


### General Description

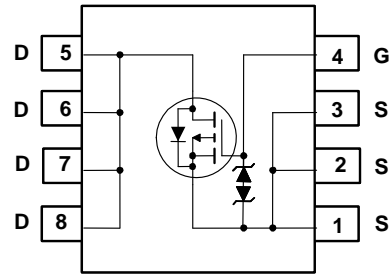
This P-Channel MOSFET is produced using Fairchild Semiconductor's advanced Power Trench<sup>®</sup> process that has been especially tailored to minimize the on-state resistance. This device is well suited for Power Management and load switching applications common in Notebook Computers and Portable Battery Packs.

### Applications

- High side in DC-DC Buck Converters
- Notebook battery power management
- Load switch in Notebook



Power 56



### MOSFET Maximum Ratings $T_A = 25$ °C unless otherwise noted

Symbol	Parameter	Ratings	Units
$V_{DS}$	Drain to Source Voltage	-30	V
$V_{GS}$	Gate to Source Voltage	±25	V
$I_D$	Drain Current -Continuous (Package limited) $T_C = 25$ °C	-18	A
	-Continuous (Silicon limited) $T_C = 25$ °C	-35	
	-Continuous $T_A = 25$ °C (Note 1a)	-9.0	
	-Pulsed	-50	
$E_{AS}$	Single Pulse Avalanche Energy (Note 3)	18	mJ
$P_D$	Power Dissipation $T_C = 25$ °C	39	W
	Power Dissipation $T_A = 25$ °C (Note 1a)	2.5	
$T_J, T_{STG}$	Operating and Storage Junction Temperature Range	-55 to +150	°C

### Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case	3.2	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	50	

### Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS4435BZ	FDMS4435BZ	Power 56	13 "	12 mm	3000 units

## Electrical Characteristics $T_J = 25\text{ }^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
$BV_{DSS}$	Drain to Source Breakdown Voltage	$I_D = -250\text{ }\mu\text{A}$ , $V_{GS} = 0\text{ V}$	-30			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = -250\text{ }\mu\text{A}$ , referenced to $25\text{ }^\circ\text{C}$		-23		mV/ $^\circ\text{C}$
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = -24\text{ V}$ , $V_{GS} = 0\text{ V}$			-1	$\mu\text{A}$
$I_{GSS}$	Gate to Source Leakage Current	$V_{GS} = \pm 25\text{ V}$ , $V_{DS} = 0\text{ V}$			$\pm 10$	$\mu\text{A}$

## On Characteristics

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$ , $I_D = -250\text{ }\mu\text{A}$	-1.0	-1.9	-3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = -250\text{ }\mu\text{A}$ , referenced to $25\text{ }^\circ\text{C}$		6		mV/ $^\circ\text{C}$
$r_{DS(on)}$	Static Drain to Source On Resistance	$V_{GS} = -10\text{ V}$ , $I_D = -9.0\text{ A}$		15	20	m $\Omega$
		$V_{GS} = -4.5\text{ V}$ , $I_D = -6.5\text{ A}$		22	37	
		$V_{GS} = -10\text{ V}$ , $I_D = -9.0\text{ A}$ $T_J = 125\text{ }^\circ\text{C}$		21	28	
$g_{FS}$	Forward Transconductance	$V_{DS} = -5\text{ V}$ , $I_D = -9.0\text{ A}$		25		S

## Dynamic Characteristics

$C_{iss}$	Input Capacitance	$V_{DS} = -15\text{ V}$ , $V_{GS} = 0\text{ V}$ , $f = 1\text{ MHz}$		1540	2050	pF
$C_{oss}$	Output Capacitance			290	390	pF
$C_{rss}$	Reverse Transfer Capacitance			260	385	pF
$R_g$	Gate Resistance			5		$\Omega$

## Switching Characteristics

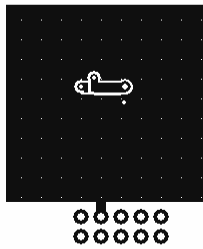
$t_{d(on)}$	Turn-On Delay Time	$V_{DD} = -15\text{ V}$ , $I_D = -9.0\text{ A}$ , $V_{GS} = -10\text{ V}$ , $R_{GEN} = 6\text{ }\Omega$		9	17	ns	
$t_r$	Rise Time			10	18	ns	
$t_{d(off)}$	Turn-Off Delay Time			35	56	ns	
$t_f$	Fall Time			19	33	ns	
$Q_g$	Total Gate Charge		$V_{GS} = 0\text{ V to } -10\text{ V}$		34	47	nC
$Q_g$	Total Gate Charge		$V_{GS} = 0\text{ V to } -4.5\text{ V}$	$V_{DD} = -15\text{ V}$ , $I_D = -9.0\text{ A}$	18	25	nC
$Q_{gs}$	Gate to Source Charge			5		nC	
$Q_{gd}$	Gate to Drain "Miller" Charge			9		nC	

## Drain-Source Diode Characteristics

$V_{SD}$	Source to Drain Diode Forward Voltage	$V_{GS} = 0\text{ V}$ , $I_S = -1.9\text{ A}$ (Note 2)		0.75	1.2	V
		$V_{GS} = 0\text{ V}$ , $I_S = -9.0\text{ A}$ (Note 2)		0.86	1.5	
$t_{rr}$	Reverse Recovery Time	$I_F = -9.0\text{ A}$ , $di/dt = 100\text{ A}/\mu\text{s}$		25	39	ns
$Q_{rr}$	Reverse Recovery Charge			12	21	nC

Notes:

- $R_{\theta JA}$  is determined with the device mounted on a 1 in<sup>2</sup> pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.



a) 50  $^\circ\text{C}/\text{W}$  when mounted on a 1 in<sup>2</sup> pad of 2 oz copper



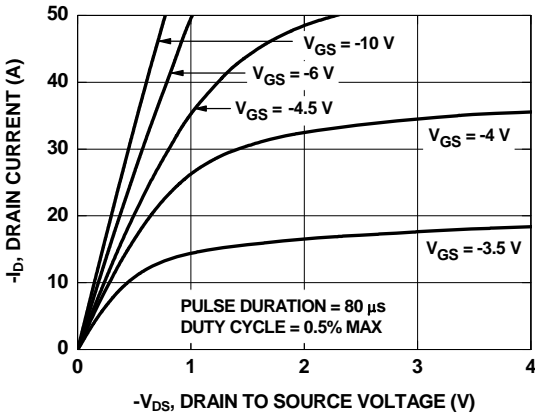
b) 125  $^\circ\text{C}/\text{W}$  when mounted on a minimum pad of 2 oz copper.

2. Pulse Test: Pulse Width < 300  $\mu\text{s}$ , Duty cycle < 2.0%.

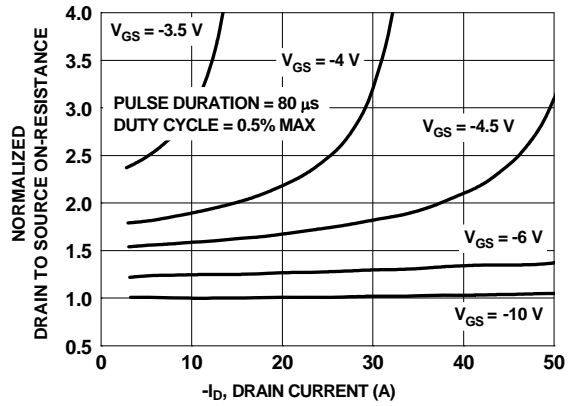
3.  $E_{AS}$  of 18 mJ is based on starting  $T_J = 25\text{ }^\circ\text{C}$ ,  $L = 1\text{ mH}$ ,  $I_{AS} = -6\text{ A}$ ,  $V_{DD} = -27\text{ V}$ ,  $V_{GS} = -10\text{ V}$ . 100% tested at  $L = 0.3\text{ mH}$ ,  $I_{AS} = -8\text{ A}$ .

4. The diode connected between the gate and source serves only as protection against ESD. No gate overvoltage rating is implied.

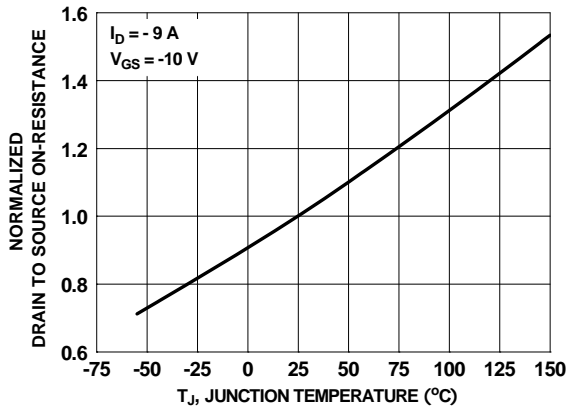
**Typical Characteristics**  $T_J = 25\text{ }^\circ\text{C}$  unless otherwise noted



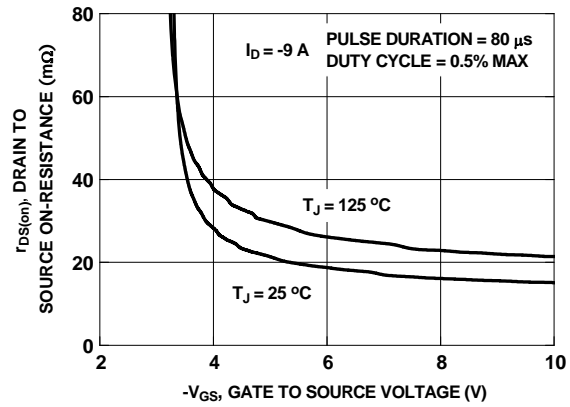
**Figure 1. On-Region Characteristics**



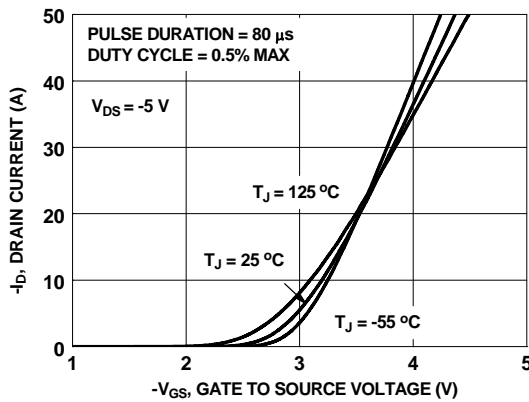
**Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage**



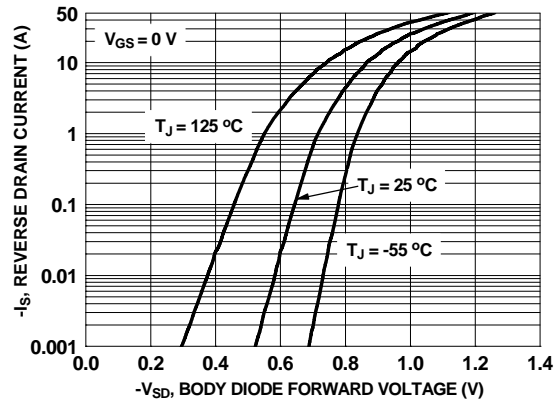
**Figure 3. Normalized On-Resistance vs Junction Temperature**



**Figure 4. On-Resistance vs Gate to Source Voltage**

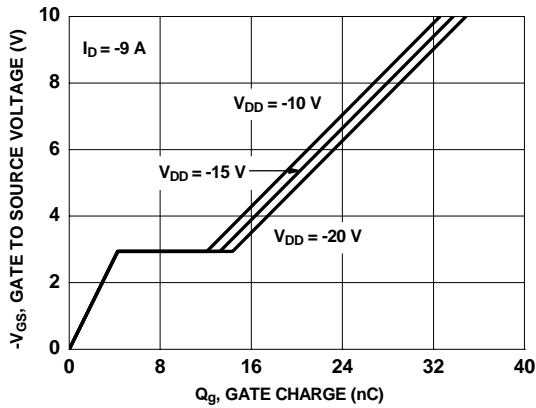


**Figure 5. Transfer Characteristics**

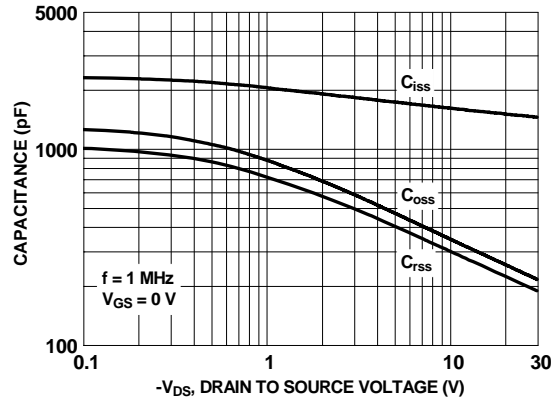


**Figure 6. Source to Drain Diode Forward Voltage vs Source Current**

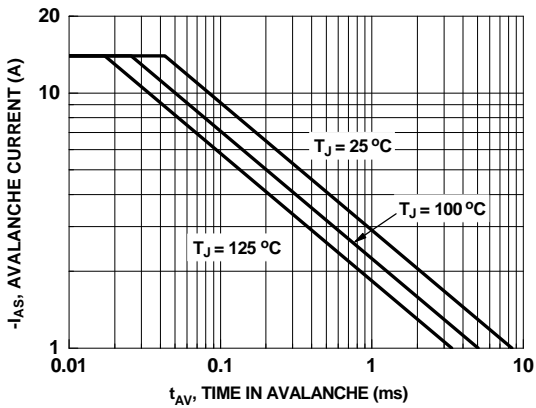
**Typical Characteristics**  $T_J = 25\text{ }^\circ\text{C}$  unless otherwise noted



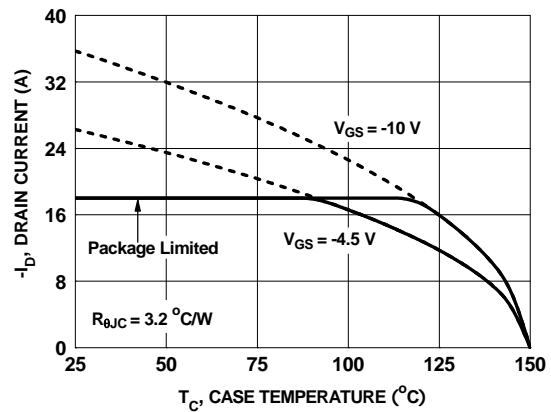
**Figure 7. Gate Charge Characteristics**



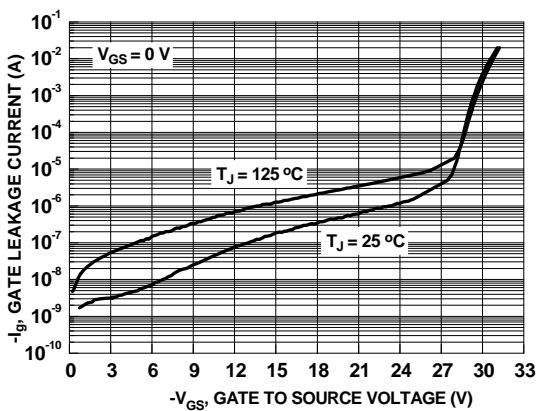
**Figure 8. Capacitance vs Drain to Source Voltage**



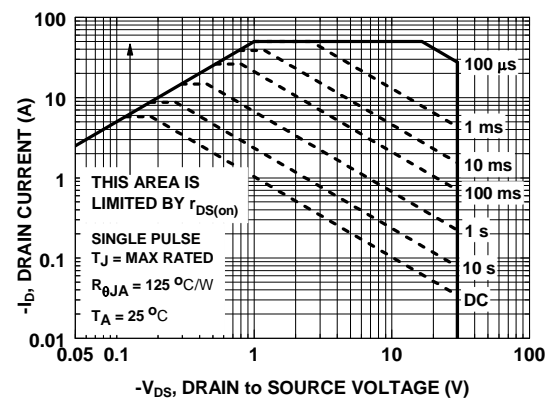
**Figure 9. Unclamped Inductive Switching Capability**



**Figure 10. Maximum Continuous Drain Current vs Case Temperature**

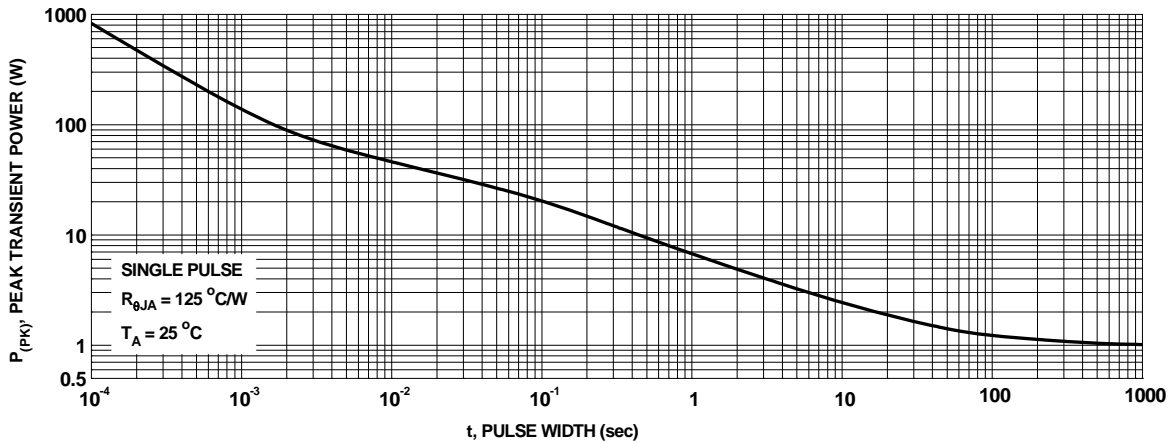


**Figure 11. Gate Leakage Current vs Gate to Source Voltage**

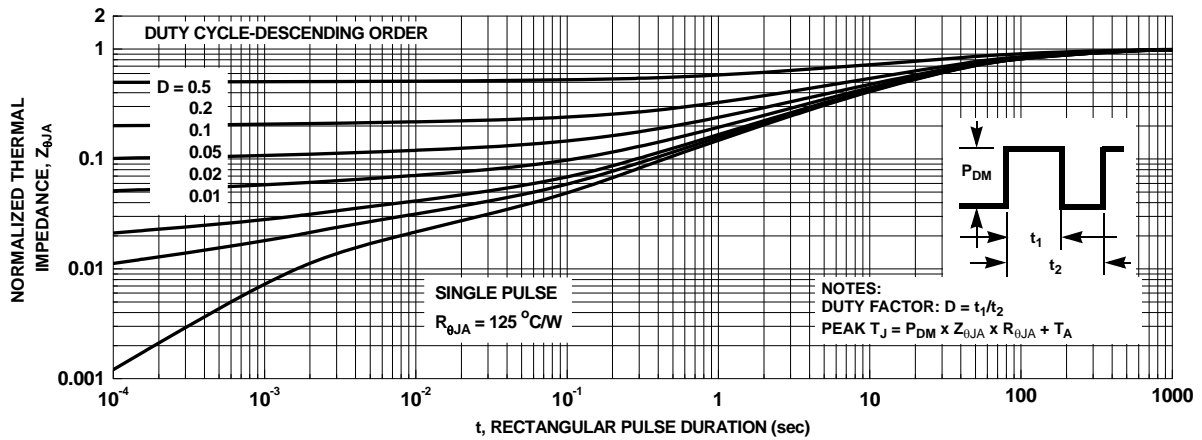


**Figure 12. Forward Bias Safe Operating Area**

**Typical Characteristics**  $T_J = 25\text{ }^\circ\text{C}$  unless otherwise noted

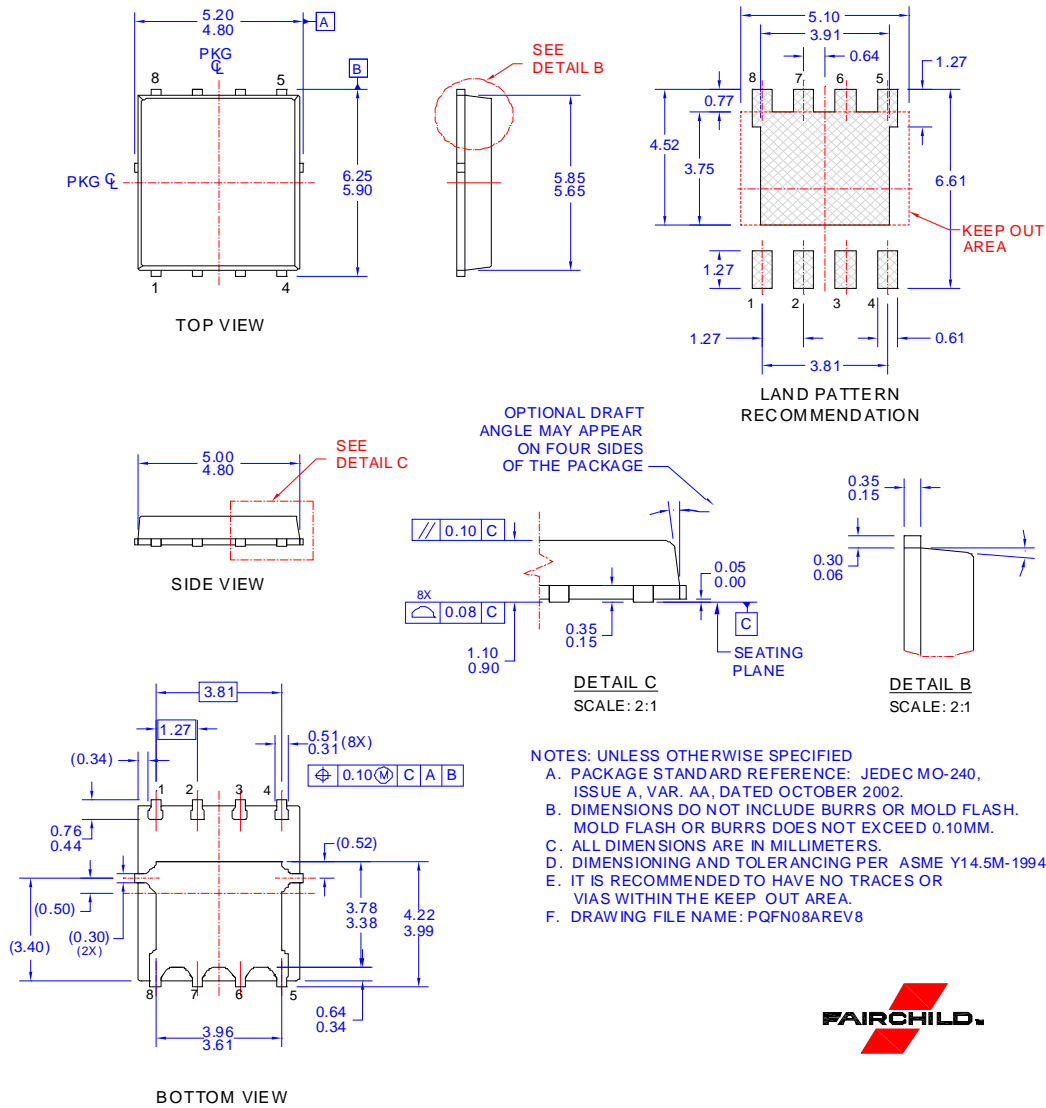


**Figure 13. Single Pulse Maximum Power Dissipation**



**Figure 14. Junction-to-Ambient Transient Thermal Response Curve**

## Dimensional Outline and Pad Layout








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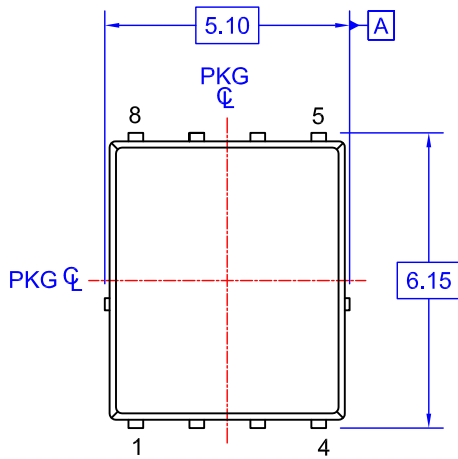
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**Definition of Terms**

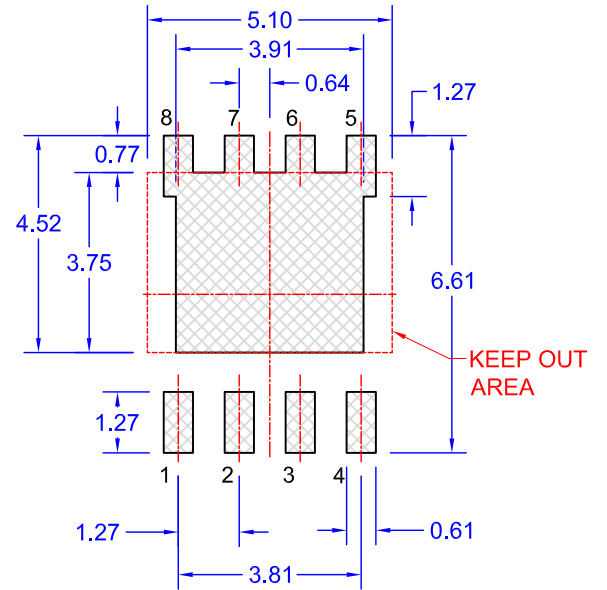
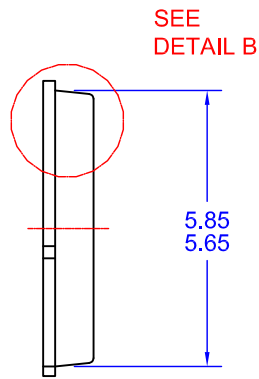
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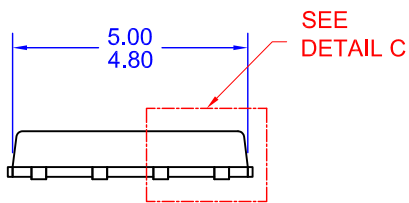




TOP VIEW

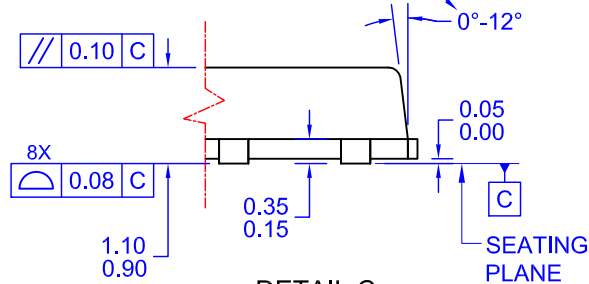


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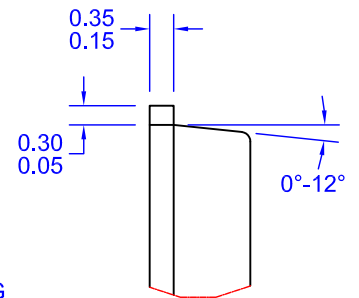


SIDE VIEW

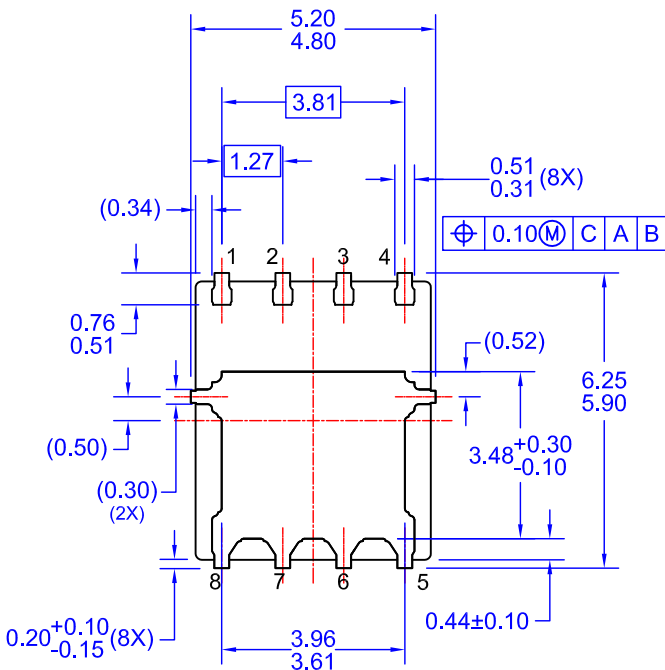
OPTIONAL DRAFT ANGLE MAY APPEAR ON FOUR SIDES OF THE PACKAGE



DETAIL C  
SCALE: 2:1



DETAIL B  
SCALE: 2:1



BOTTOM VIEW

- NOTES: UNLESS OTHERWISE SPECIFIED
- A. PACKAGE STANDARD REFERENCE: JEDEC MO-240, ISSUE A, VAR. AA, DATED OCTOBER 2002.
  - B. DIMENSIONS DO NOT INCLUDE BURRS OR MOLD FLASH. MOLD FLASH OR BURRS DOES NOT EXCEED 0.10MM.
  - C. ALL DIMENSIONS ARE IN MILLIMETERS.
  - D. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-2009.
  - E. IT IS RECOMMENDED TO HAVE NO TRACES OR VIAS WITHIN THE KEEP OUT AREA.
  - F. DRAWING FILE NAME: PQFN08AREV10



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